A m orphous silica between con ning walls and under shear: a com puter sim ulation study

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Abstract

M olecular dynam ics com puter sim ulations are used to investigate a silica m elt con ned between walls at equilibrium and in a steady (state Poisseuille ow. The walls consist of point particles form ing a rigid face (centered cubic lattice and the interaction of the walls with the melt atom s is modelled such that the wall particles have only a weak bonding to those in the melt, i.e. much weaker than the covalent bonding of a Si{O unit. We observe a pronounced layering of the melt near the walls. This layering, as seen in the total density pro le, has a very irregular character which can be attributed to a preferred orientational ordering of SiO 4 tetrahedra near the wall. On interm ediate length scales, the structure of the melt at the walls can be well distinguished from that of the bulk by m eans of the ring size distribution. W hereas essentially no structural changes occur in the bulk under the in uence of the shear elds considered, strong structural rearrangem ents in the ring size distribution are present at the walls as far as there is a slip motion. For the sheared system, parabolic velocity pro les are found in the bulk region as expected from hydrodynam ics and the values for the shear viscosity as extracted from those pro les are in good agreement with those obtained in pure bulk simulations from the appropriate G reen {K ubo form ula.

I. IN TRODUCTION

The transport properties of atom ic uids that move through nanoscopic slits between solid walls has been an issue of constant interest over the past decades [1{5]. M any of the simulation studies investigating such uids in Couette or Poisseuille ow have considered simple m onoatom ic systems in which the particles interact via Lennard (Jones (LJ) type forces (see, e.g., [6{9]}). One of the remarkable results of these studies was that velocity proles as predicted by hydrodynam ics can be observed even if the distance between the con ming walls is of the order of only ten molecular diam eters. But one has to keep in m ind that the monoatom ic LJ systems for which this was found have typically a relatively sm all viscosity (of the order of 10⁴ to 10³ Poise in Argon units) and furtherm ore, these systems crystallize very easily if one decreases the tem perature below the melting point. An open question is what happens with more complicated sheared uids that are con ned between walls, i.e. especially liquids that have a structure that is not similar to the local structure

of a closed {packed system of hard spheres like the aforem entioned LJ system s. One class of more complex materials for which ow properties in connement have already been studied to some extent are polymermelts [12{18]. Very recently it was shown [18] for such a system that its properties under shear can be well understood within a hydrodynamic description.

In this paper we are interested in amorphous silica (SiO₂) which is the paradigm of a network forming liquid. We consider a SiO₂ melt that is con ned between two crystalline walls and on which a gravitational { like eld is exerted in order to yield a stationary Poisseuille ow. It is di cult to address this problem in a simulation because model potentials of silica contain long { ranged C oulom b term s [19] for which the corresponding force calculations become very time {consuming for a three dimensional system in which periodic boundary conditions are considered only in two directions. This stem s from the fact that the Fourier part of the Ewald sum s can no longer be calculated by a single loop over the number of particles N as in the case of periodic boundary conditions in three dimensions, but one has to compute a double bop that scales with N 2 [20{23]. Therefore, very recently, many e orts were undertaken to develop alternative m ethods $[24\{27\}]$ for the sum m ation of $two{$ dim ensional" Coulom b interactions. But most of these new approaches are not established yet and extensive tests that demonstrate that their accuracy is comparable to the \brute force" N² {m ethods are still lacking. M oreover, di erently from m onoatom ic LJ system s, silica is a good glassform er that exhibits a slow dynam ics even above the melting tem perature. Note that at the experimental melting temperature, T = 2000 K, am orphous silica has a viscosity of about 10⁷ Poise [28]. System s with such a high viscosity cannot be equilibrated now adays by means of a molecular dynamics computer simulation.

The structure of silica is that of a disordered tetrahedral network in which SiO 4 tetrahedra are connected to each other in that they share an oxygen atom at their corner. Extensive simulation studies of free silica surfaces, that used both classical molecular dynamics as well as $Car{Parrinello}$ simulations [30,31] gave evidence for a di erent packing of the SiO 4 tetrahedra at the surface from that in the bulk. This di erent packing is manifested very clearly in the ring structure (a ring is a closed loop form ed by consecutive Si(0 elements). At the surface there is a relatively high probability to nd short rings such as two{ and three{m em bered rings whereas in the bulk the occurence of such rings is very rare even at relatively high tem peratures. Note that the occurrence of short rings on a free silica surface has been con med experimentally by means of atom ic force microscopy [32]. A detailed understanding of the structure near the wall is in portant to give insight into the m icroscopic origin of the wall { uid boundary conditions if a ow eld is introduced. This m ight be especially important in the case of silica since it does not form a closed (packed structure and thus the behavior could be very di erent from that of a hard{sphere like system. Indeed we show below that there is a rearrangement in the ring distribution near the walls if the shear is strong enough.

An important issue for the understanding of a conned uid under shear are the boundary conditions that enter in the hydrodynamic description in order to take into account the interactions of the uid with the wall. In principle, these boundary conditions can be derived from the microscopic equations of motion for the uid and the wall particles. But in practice one often introduces as an ad hoc assumption stick boundary conditions. However, it has been found in simulations of simple uids that there is often a slip motion of the uid at the wall [10,11]. So in general one has to consider slip (stick boundary conditions

2

for a hydrodynamic analysis of uid ow between walls. Bocquet and Barrat [33] have shown in a microscopic theory, in which they have related quantities like the slip length with equilibrium time correlation functions via G reen {K ubo form ulas, that slip occurs if the walls do not provide a strong corrugation. E g., a large slip e ect is observed if the uid partially wets the solid walls. In a recent simulation of Sokhan et al. [34] it has been even demonstrated for the uid ow through a carbon tube that slip {stick boundary conditions are the generic case if one uses realistic parameters in the model potential for the wall{ uid interactions. It is one of the issues of this paper to characterize the structure of the silica melt near the wall and to see how the structure is related to the observed boundary conditions.

Another issue that we address in this paper is to discuss to what extent the velocity proles from our simulations can be used to estimate the shear viscosity of a highly viscous uid such as silica. An alternative method is to calculate from the appropriate G reen { Kubo formula [35] which expresses as the time integral over a stress{stress autocorrelation function. We applied the latter approach recently in extensive bulk simulations of silica in which we were able to determ ine in the temperature range 6100 K T 3000 K whereby at T = 3000 K the viscosity is of the order of 60 Poise [36]. In the present paper we use the latter results as a reference to see how reliable the estimates of from our non{equilibrium simulations are. Such a reference is important since it is not obvious that the observed velocity proles justify a \hydrodynamic analysis" keeping in mind that the distance between the con ning walls is on a nanoscopic scale.

The rest of the paper is organized as follows: In Sec. II we describe how we model the walls and the silica melt, and we give the details of the simulation. Sec. III is then devoted to the presentation of the results and eventually, in Sec. IV we summarize and discuss them.

II.M ODEL AND DETAILS OF THE SIM ULATION

A realistic simulation of silica con ned between walls requires an interaction potential that yields a reliable description of both the bulk properties and the properties at the interface between the walls and the silica uid. As far as the bulk properties are concerned recent simulations have shown that the potential that was proposed some years ago by van Beest et al. [37] (the so{called BKS potential) is able to reproduce various properties of am orphous silica very well, such as its structure, its vibrational and relaxational dynamics, the static speci c heat below the glass transition tem perature, and the conduction of heat [36,38{45]. Recent extensive simulations [31] that used a combination of a classicalm olecular dynamics simulation with the BKS potential and ab initio simulations (Car{Parrinello m olecular dynamics) gave evidence that the BKS potential yields also a fair description of the structure of free am orphous silica surfaces, and thus, it can be expected that it also reproduces the main features of the structure of am orphous silica near a wall.

The functional form of the BKS potential is given by

$$(\mathbf{r}) = \frac{q q e^2}{r} + A \exp(B r) \frac{C}{r^6} ; 2 [Si;0];$$
(1)

where r is the distance between the ions of type and . The values of the constants q;q;A;B, and C can be found in Ref. [37]. For the sake of computational e ciency

the short range part of the potential was truncated and shifted at 5.5 A. This truncation has also the benet to improve the agreem ent between the density of the am orphous glass at low temperatures as determined from the simulation with the experimental value. For the calculation of the long{ranged C oulomb interactions we used the method rst introduced by P arry [20,21] which is a straightforward generalization of the three{dimensionalEwald sums with periodic boundary conditions in all three directions. In the latter case the Fourier sum requires only a loop over the N particles of the system which leads, together with the real space sum, to an elective computational load that scales as N^{1:5} [29]. In contrast to that in the Parry{Ewald sum s for system s with a quasi{two{dimensional geometry the Fourier and the real space part have to be computed by a double loop over all pairs of particles. However, we preferred to use Parry{Ewald sum s rather than alternative faster methods [24{27}] since it provides accurate results and it is easy to implement.

The walls were not constructed as to model a particular material but rather to be a generic surface that can be simulated conveniently. Each wall hence consisted of 563 point particles forming a rigid face{centered cubic lattice with a nearest{neighbor distance of 2:33 A. These point particles interact with the atoms in the uid according to a 12{10 potential,

$$v(r) = 4^{h} (=r)^{12} (=r)^{10^{i}};$$
 (2)

with = 2:1 A, = 1:25 eV, r being the distance between a wallparticle and a SiorO atom. Note that we choose the same potential between the wall atom s and both Si and O because we wish to simulate the generic e ects of con nement, separated from possible additional e ects due to surface enrichment of one component caused by the di erence in surface forces, which m ay be a problem in m any real system s. The great advantage of simulation is that by idealizing certain aspects of a problem a much better physical understanding of consequences of particular interactions m ay be achieved. In this spirit, a wall potential has been \invented" that keeps the slip small (when we apply a constant force in x {direction to the particles causing a corresponding ow) and provides at the same time a weak bonding of the wall particles to those of the m elt such that no covalent bonds of wall particles with SiorO atom s are form ed. In order full these two \requirements" the r¹⁰ {term in Eq. (2) has turned out to be more suitable than a r⁶ {term.

The sinulation box had linear dimensions $L_x = L_y = 23.066$ A in the directions parallel to the walls (in which also periodic boundary conditions were applied), and $L_z = 31.5$ A in the direction perpendicular to the walls. Thus, N = 1152 atoms (384 Si atoms and 768 O atoms) were contained in the system to maintain a density around 2.3 g=cm³ which is close to the experimental one at zero pressure [28]. In the Parry{Ewald sums the parameter and the cuto wave{vector for the Fourier part were chosen to 0.265 and 6, respectively [29]. The equations of motion were integrated with the velocity form of the Verlet algorithm with a time step of 1.6 fs. All runs were done in the N V T ensemble whereby the temperature was kept constant by coupling the uid to a N ose{Hoover therm ostat [46{48}]. W henever an external gravitational{like eld was switched on, the therm ostat was only applied in the two directions perpendicular to the ow, i.e. in y{ and z{direction, whereas otherwise the therm ostat was used in all three directions. Bocquet and Barrat [11] also em barked on this strategy to provide a correct adjustment of the tem perature when the system is sheared.

W e investigated the three tem peratures T = 5200 K , T = 4300 K , and T = 3760 K at

which we rst fully equilibrated the system for 29 ps, 65 ps, and 122 ps, respectively. At T = 5200 K and T = 3760 K we continued with additional runs over 164 ps and 490 ps, respectively, from which we analyzed the equilibrium structure. Then we switched on a gravitational acceleration eld of strength $a_e = 9:6$ A =ps² that was coupled to the mass of the particles. W e mention that although the masses of oxygen and silicon di er by about a factor of two ($m_0 = 15:9994$ u, $m_{Si} = 28:086$ u) we obtained identical velocity pro les for both species (see below), and this is due to the fact that the dhem ical bonding force between oxygen and silicon atoms is much stronger than the imposed acceleration eld. W ith the acceleration eld runs were made over 736 ps, 123 ns, and 327 ns at T = 5200 K, 4300 K, and 3760 K, respectively. In addition at T = 5200 K we did a run over 1:72 ns with eld strength $a_e = 3:8$ A =ps². During these runs we stored the positions and velocities of the particles every 0:16 ps (i.e. every 100 time steps). For the calculation of the steady state properties we used only those data that were obtained after two times the time that was used before for the equilibration. The total am ount of com puter time spent for these simulations was 16 years of single processor time on a C ray T 3E.

III.RESULTS

In this section we present the simulation results for the silica melt between con ning walls. We characterize the structure of the melt and show how it changes if one switches on a gravitational ed, i.e., if a Poisseuille ow is present in the melt. By analyzing the velocity proles we discuss to what extent their behavior can be understood within a hydrodynamic description.

The snapshot, Fig. 1, illustrates on what length scales the walls a ect the structure of the melt. It shows a part of a con guration at T = 3760 K, namely the part that is within a distance less than 8 A away from one of the walls. One can clearly identify a layering of SiO₄ tetrahedra which becomes less pronounced if one moves away from the wall. Note that at T = 3760 K 95% of the silicon atom s are four{fold coordinated by oxygen atom s and 96.5% of the oxygen atom s are two{fold coordinated by silicon atom s (a silicon and an oxygen atom are de ned as neighbors if their distance is less than 2:35 A corresponding to the rst m inim um of the pair correlation function for Si{O}. The rest of the atom s form defects, i.e. silicon atom s that are three{ or ve{fold coordinated by oxygen atom s and oxygen atom s that are one{ or three{fold coordinated by silicon atom s. Thus, since less than 5% of the atom s are involved in such defects it makes sense to characterize the structure also at the relatively high temperature T = 3760 K as a disordered tetrahedral network where SiO₄ tetrahedra are connected via bridging oxygens (i.e. every oxygen atom belongs to two tetrahedra).

The layering of the SiD₄ network near the wall can be quantiled by means of the density prolewhich is plotted in Fig.2a across half of the lm [49] for all atom s and for the oxygen and silicon atom s only. In contrast to typical density proles in simple monoatom ic liquids the oscillations of the total prole, which indicate the layering near the walls, do not have a regular character. But this irregular behavior can be understood if one looks at the partial proles for oxygen and silicon. The explanation that emerges is as follows: A swem entioned before con ned uid SiD₂ maintains the irregular network SiD₄ tetrahedra as in the bulk. At the same time the tetrahedra have to lithe available space and have to satisfy the bonding

energy to the wall. To this end, it is necessary to align the tetrahedra adjacent to the wall such that a two{dimensionalplane forms which contains three out of the four oxygen atoms of a tetrahedron, as well as the silicon atom at their center (slightly further away from the wall), while the fourth oxygen atom of the tetrahedron has to be further away from the wall for geometrical reasons: this causes the second peak of the oxygen distribution. Thus, the walls have a tendency to \orient" the network of coupled SiO₄ tetrahedra in the uid locally. It is evident that the oscillations in the local density of both silicon and oxygen are rather regular, like a dam ped cosine function, but the wavelength and phase of both cosine functions are di erent: their superposition causes then the rather inregular layering structure of the SiO₂ total density. We expect that sim ilar e ects also occur in m any other associating m olecular uids con ned between walls if the wall{ uid interaction is weak enough that it does not a ect the chem ical ordering in the uid as it is the case in our system.

For z > 8 A the total density prole shows only small oscillations around a constant value of 2.3 g=cm³ which is an indication for bulk behavior. Thus, keeping in mind that the density prole is symmetric, the bulk in our system seems to extend in z direction from about 8 A to 23.5 A, i.e. it has a width of about 15.5 A. However, Fig. 2a shows that the deviations from a constant density in the latter region are not due to the statistics: The partial density proles exhibit still oscillations also in the middle of the lm that one would not expect in a pure isotropic bulk system. But these oscillations do not a left the structural quantities that we show below, i.e. the pair correlation functions and the distributions of angles and rings, since these quantities essentially do not dier from the corresponding ones of a pure bulk simulation at the same temperature. Therefore, we consider in the following the region de ned by 8 A z 23.5 A as the bulk.

The behavior of the total density proles at the temperatures T = 5200 K and T = 3760 K in equilibrium and with an external force with an acceleration of 9.6 A = ps² can be seen in Fig. 2b. In equilibrium the elect of decreasing temperature on the oscillations near the wall is an increase of the peak heights that is accompanied with a smaller value of (z) at the minim a between the peaks. Thus, the layering becomes more pronounced if one decreases the temperature. If one switches on the gravitational{like eld the elect is similar to an increase of the perature. In the bulk region the density proles are not very sensitive to a variation of temperature and/or the presence of the external force. Within the accuracy of our data the same value of about 2.3 g=cm³ is reached for all four cases under consideration. However, this does not exclude of course the possibility of a dram atic change in the local structure, but as we will see in the follow ing, the local structure is not strongly a ected by the considered external forces.

Q uantitities that provide inform ation on the microscopic interparticle distances are the partial pair correlation functions g (r) which are proportional to the probability of nding an atom of type at a distance r from an atom of type . In an isotropic system the functions g (r) are normalized by a phase factor 4 r^2 [35]. However, for the case that boundaries are present this factor has to be modiled in that it is then determined only by that part of the surface 4 r^2 of a sphere around a particle that the system of the surface 4 r^2 of a sphere around a particle that the system of the surface factor depends on the distance of the particles from the walls in z (direction. In order to identify the di erences of g (r) close to the wall from those of the bulk we de ne a bulk region for 8 A z 23.5 A and wall regions for distances less or equal 3 A from the wall (containing respectively the rst oxygen and silicon layer, see Fig. 2a).

The latter wall layer is denoted in the following by W L.The g (r) are calculated only for particles within the bulk or the W L whereby the aforem entioned normalization factors are determined such that also the boundaries of the bulk region and the W L that are located within the uid lm are treated as real boundaries. Fig. 3 shows g (r) for the di erent correlations at T = 3760 K, each at equilibrium in the bulk and in the W L, as well as in the W L under the acceleration eld $a_e = 9.6 \text{ A/ps}^2$. We have not included the curves for the bulk with an external eld because they essentially coincide with the equilibrium curves. This means that for the eld strength $a_e = 9.6 \text{ A/ps}^2$ the structure as related in g (r) is not a ected in the bulk by the gravitational eld. From this we can consider the latter eld strength as a small disturbance, and thus we can expect that the system can be treated as a Newtonian uid in the bulk. In contrast to this at the walls there are signi cant changes in g (r) if one switches on the external eld in that the peaks become broader and their heights decrease slightly. These changes are most pronounced in g_{00} (r) which is reasonable since the very is layer at the wall is form ed by oxygen atom s.

The di erences in g (r) at the W L and in the bulk re ect the di erent packing of the tetrahedral network in both regions. In g_{SiD} (r) the second and third peaks are shifted to smaller distances in the bulk as compared to the W L. Sim ilar e ects are even more pronounced in g_{00} (r) and g_{SiSi} (r). In these functions one can see that the frc lattice of the wall a ects the structure on length scales of next{nearest Si{Si and 0 {0 neighbors. In g_{00} (r) for the W L the periodicity of the peaks is approximately given by the lattice constant a = 2.33 A of the frc lattice that is formed by the wall atom s. This periodicity appears less pronounced in g_{SiSi} (r) since the Si atom s are not so close to the wall as the 0 atom s and have thus more freedom to arrange them selves. Moreover the rst peak in g_{SiSi} (r) is at a slightly smaller distance for the W L than for the bulk and this is due to the denser packing of SiD₄ tetrahedra near the wall.

A further step towards the characterization of the local structure is to consider correlations between triples of particles. Simple quantities to study such correlations are the distributions of angles between three neighboring atom s. Thereby, two atom s of type and

are de ned as neighbors if their distance is smaller than the position of the rst minimum in the corresponding q (r). The locations of these minima are at 3.64 A, 2.35 A, and 321 A for the Si{Si, Si{O, and O {O correlations, respectively. In Fig. 4a we show the angle distribution functions P () for the Si{Si{Si, Si{O} {Si, and the O} {Si{O} angles in the bulk at equilibrium and under shear and at the W L at equilibrium. The tem perature in all cases is 3760 K.We see in the gure that in each of the P () shown there are only small di erences between the bulk curves for the equilibrium and the sheared case which again dem onstrates that the structure changes only slightly in the bulk region if a eld of strength $a_e = 9.6 \text{ A} = ps^2$ is switched on. There are also only small di erences in P_{OSiO} for the W L as compared to the corresponding distributions in the bulk. Since the O {Si{O angle is an intratetrahedral one this shows that the geometry of the SiO $_4$ tetrahedra is essentially the same at the wall and in the bulk. Remarkable di erences are in P_{SiSiSi} and P_{SiSiSi} for the W L as compared to corresponding functions for the bulk: First, the main peak in P_{SiOSi} is shifted towards smaller angles which is due to the denser packing of the tetrahedra in the W L. Secondly, there is a shoulder in P_{siosi} around 100 which is less pronounced in the W L and P_{sisisi} exhibits a secondary peak at about 60 which is more pronounced in the curve for the W L. In Fig. 4b we compare the di erent P () for the W L at equilibrium and for the sheared system . As can be inferred from the gure, in contrast to the bulk case there are changes in the angular distributions in that all three distributions broaden signi cantly for the system under shear. Moreover, the shoulder in P_{siosi} around 100 has about a six times larger amplitude in the latter case.

Recent studies of silica melts [30,31] have shown that the shoulder around 100 in P_{SiDSi} is due to two{membered rings whereas the peak at about 60 in P_{SiDSi} corresponds to the presence of three{membered rings. We look now for the latter ring sizes in our system and investigate the distribution of rings in the network. A ring is de ned as follows: One starts from any silicon atom and two of its nearest oxygen neighbors. Then one counts the shortest consecutive sequence of Si{O elements that connect the two latter oxygen atom s and this number is then the ring length n. Thereby, the ring length n = 1 corresponds to a dangling bond, i.e., an O atom is only attached to one Siatom, and in a two{membered ring (n = 2) two silicon atom s share two oxygens. Note that one can extract (indirectly) inform ation on rings in SiD₂ by means of NMR experiments [50].

Fig. 5a shows the ring distribution function P (n) for T = 3760 K in the bulk and in two di erent wall layers denoted by W L1 and W L2. W L1 and W L2 are de ned as the regions which are respectively within a distance of 625 A and 3.0 A away from the wall corresponding to the second m in im um of the density pro le for silicon and the rst m in im um of the total density pro le, respectively (see Fig. 2a). Note that W L2 is identical with W L. In each region, i.e. bulk, W L1, and W L2, we took only those rings into account that t completely into it. Thus, in W L2 those rings are counted that are formed at each case by the rst and the second O and Si layers (with respect to the distance from the wall), whereas with W L2 only those rings are taken into account that are formed by the rst 0 and the rst Silayer. This is justilled because the rst two oxygen and the rst two silicon layers are well de ned in that the minim a in the corresponding density pro les are close to zero density in the case of W L2 and around the small value = 0.5 g=cm³ in the case of W L1. Furtherm ore, we can infer from Fig. 2a that in contrast to the second layers the rst oxygen layer overlaps strongly with the st silicon layer and the overall thickness of both layers is only about 2 A. Thus, the rst oxygen and the rst silicon layer form a quasi{two{ dim ensional plane and P (n) for W L2 gives a distribution of rings that have an orientation parallel to the walls whereas in P (n) for W L1 also the rings perpendicular to the walls are included.

As has been also found in pure bulk simulations of SiO₂ [38], in the bulk a maximum is observed around n = 6. This is plausible since in silica the high {tem perature crystalline phase at zero pressure, {cristobalite, exhibits only six {membered rings. In W L1 the probability for n 6 is smaller than in the bulk in favor of a relatively high probability of n = 3 and n = 4. In W L2 it is the other way round: n = 4 and even more n = 5 are less frequent than in the bulk in favor of n = 8;9;10. The ring structure near the walls that corresponds to these notings is as follows: Perpendicular to the walls small rings with n = 3;4 are seen such that, e.g., n = 3 is formed by two silicon atoms from the rst silicon layer with a third one from the second silicon layer (for an illustration see Fig.1). In contrast to that, parallel to the walls (considering the rst oxygen and the rst silicon layer) an open structure with relatively large rings is observed which compensates som ewhat the dense packing of SiO₄ tetrahedra perpendicular to the walls.

Fig. 5b shows the behavior of P (n) in the bulk at the two tem peratures T = 3760 K

and T = 5200 K in equilibrium and under shear. We can immediately infer from the gure that the considered shear elds have only a smalle ect on the structure which con rms the ndings for all the quantities discussed before. At T = 5200 K one has a relatively large amount of two{ and three{membered rings the frequency of which is more than a factor of two smaller at T = 3760 K. In Ref. [38] it was shown that their frequency of occurrence decreases further with decreasing temperature such that the amount of two{membered rings falls far below 1% for systems that have typical structural relaxation times of the order of 1 ns.

In contrast to the bulk in W L1 signi cant changes in the ring distribution take place if the system is sheared (see Fig. 5c), and the external force eld a ects the ring structure such that sm all and large rings are form ed, while at the same time especially the am ount of six { m embered rings decreases. Only for the sm aller eld strength $a_e = 3.8 \text{ A} = ps^2$ there are no signi cant changes in the ring distribution. We will see below that the latter is accompanied with a very sm all slip motion at the walls whereas a large slip velocity is correlated with strong rearrangements in the ring structure. One can also infer the remarkable fact from Fig. 5c that the probability to nd rings with n = 3;4 does not change very much when an external acceleration eld is switched on. This is reasonable because these sm all{m embered} rings, as we have seen before, are located perpendicular to the walls and thus they are very stable to shear forces that are imposed parallel to the walls.

The strongest rearrangements in the ring structure due to a shear eld are found when we consider the region W L2. The corresponding curves are shown in Fig. 5d. Again, there are only minor changes in P (n) at T = 5200 K and $a_e = 3.8 \text{ A}=ps^2$ as compared to the corresponding equilibrium case which is, as mentioned before, related to the presence of only a very small slip velocity. For the higher acceleration eld, $a_e = 9.6 \text{ A}=ps^2$, the ring structure becomes more heterogeneous and the e ect of the external eld is if one would locally increase the temperature. The rearrangements in the ring structure can be summarized as follows: Ringsmainly of size n = 6;7;8 are broken under the in uence of the shear force and instead small rings with n < 4 and very large rings with n = 9 are formed. This is illustrated in Fig. 6 where snapshots at T = 3760 K of the W L2 region are shown for the equilibrium case and the non {equilibrium steady state case with the external eld of strength $a_e = 9.6 \text{ A}=ps^2$. One can clearly identify, e.g., rings with n = 2 and n = 11 in the right panel which are absent in the left panel, i.e. at equilibrium.

Up to now we have seen that in the bulk region the structure essentially does not change for acceleration elds $a_e = 9:6 \text{ A} = ps^2$ whereas signi cant structural rearrangements occur close to the walls for $a_e = 9:6 \text{ A} = ps^2$. We demonstrate now how this is rejected in the ow properties, and we discuss to what extent the ow can be understood within a hydrodynamic description.

Fig. 7 shows velocity pro les v_x (z) across the lm for two di erent choices of the acceleration in x (direction for T = 5200 K. The solid lines are ts according to the form ula

$$v_x(z) = \frac{a_e}{2}(z - z_1)(L_z - z_1 - z)$$
 (3)

with being the total mass density, and the intercept z_1 as well as the shear viscosity are treated as adjustable parameters. Eq. (3) is the formula for a one (component uid, but it is justiled to use this equation for our two (component system since the velocity proles for the individual species, i.e. for silicon and oxygen, are identical within the statistical errors. Note that this was also observed by K oplik and Banavar [51] for a mixture of two simple liquids conned between two walls. The values of that result from the tswith Eq. (3) are quoted in the gure. As it should be, is independent of the acceleration a_e within statistical errors. This matches well to the aforementioned result that the structure is essentially not a ected in the bulk by the considered shear elds. Furthermore, this analysis shows that hydrodynamics holds down to nanoscopic scales, even if we use a realistic model of a molecular glassforming uid such as SiO₂. Close to the wall the twith Eq. (3) is obviously not valid for $a_e = 9:6 \text{ A} = ps^2$ and we nd a slip motion of the uid. As we have seen before this slip is accompanied with structural rearrangements in the ring distribution.

It is conspicuous in Fig. 7 that there is a sharp peak in $v_x(z)$ at z = 12 A in the curve for $a_e = 3.8 \text{ A} = ps^2$ (there is exactly the same peak at z = 30.3 A because the prole is symmetrized). This is just due to the fact that there is a very small probability for the particles to move into the region z < 1.5 A, i.e. the region very close to the wall. And if a particle enters this region there is a high probability that it has a relatively high velocity. O focurse, on average this velocity should be zero, but in this case the statistics is bad since this event is very rare, and we observe sharp peaks in the regions very close to the walls that can have a negative or positive amplitude with equal probability (note that they appear also in the unsheared system). A similar reasoning might be also true at z = 3 A, i.e. at the location of the rst minimum in the total density prole. Indeed we see a small peak at z = 3 A in the curve for $a_e = 9.6$ A = ps^2 which we also nd at lower temperatures (see Fig. 8). But we cannot conclude from our data whether this feature would disappear with a better statistics.

O ne still could argue that the ts with Eq. (3) are fortuitous, and therefore the resulting shear viscosity then simply is a tparameter with little physical signi cance, dierent from the actual shear viscosity of bulk molten SiO_2 . Fig. 8 shows that this objection is not true: here the velocity proles are compared at three temperatures, and the viscosities from the

ts are compared to viscosities $_{GK}$ obtained earlier from simulations of bulk SiO₂ at rest (no walls, no ow) applying G reen {K ubo form ulas [36]. Note that the latter approach typically involves a relative error of about 20%, and so does the present approach. Within these errors, there is a good agreement, although $_{GK}$ changes for the shown range of tem peratures by an order of magnitude. However, the estimated seems to be systematically smaller than $_{GK}$ at low temperatures and we cannot exclude that these deviations are due to the in uence of the Nose{Hoover therm ostat on the ow velocity. Of course, we can also infer from Fig. 8 that we cannot use our simulation of Poisseuille ow to estimate the viscosity at much low er temperatures than 3760 K : If decreases the velocity pro lebecom es atter, and one cannot compensate this by higher values of a_e since the slip velocity increases with a_e also.

IV.SUMMARY AND DISCUSSION

We used molecular dynamics computer simulations to study a silica melt con ned between two walls. The interactions between the silicon and oxygen atoms were modelled by the so{called BKS potential for which it has been shown that it describes reliably the bulk as well as free surface properties of silica. The walls consist of particles xed on a fcc lattice, and wall{ uid interactions were modelled by a simple 12{10 potential. The aim of this work was to investigate how the walls a ect the structure of the melt in equilibrium and under shear, and whether it is possible to understand the ow properties of the sheared melt within hydrodynamics.

As in the case of simple liquids a pronounced layering of the melt close to the walls is observed. This layering, as seen in the total density prole, has a very irregular character and this is related to the speci c chem ical ordering of silicon and oxygen atoms in a tetrahedral network. In the layers that are closest to the walls the tetrahedra prefer an orientation such that three oxygen atoms of each tetrahedron form the rst layer, the silicon atoms the second one and the remaining fourth oxygen atoms of the tetrahedra the third one (see Fig. 1).

It has been dem onstrated in recent simulation studies of free silica surfaces [30,31] that the ring distribution function is a quantity that is well suited to characterize the di erences of the surface structure on interm ediate length scales from that in the bulk. This holds also true in the present case: The relatively high probability of sm all and large rings m akes the di erence of the melt structure at the wall from that of the bulk. Perpendicular to the rst wall layer there is a high probability of rings of size n = 3;4 whereby, e.g., a ring with n = 3 is typically formed by two silicon atoms from the rst silicon layer and one from the second one (of course, these rings are also decorated with oxygen atom s). Parallel to the walls, at least for tem peratures T 3760 K a relatively high probability for rings of length 9 is found in the wall layers which can be seen as the complement to the occurrence n of sm all $(m \in m)$ bered rings with n = 3; 4. Our notings for the structure of the silica melt near the wall can be expected to be generic if the wall SiO 2 interactions are, as in our case, relatively weak, i.e. no covalent bonds of the wall atom swith those of the uid are form ed as it would be the case, e.g., for an interface between crystalline and am orphous silica.

Under shear, the bulk structure of the silica melt does not change for the eld strengths considered in this work, $a_e = 9:6 \text{ A} = ps^2$. This is an indication that it is justiled to treat the melt as a Newtonian uid. At the walls, the behavior of the uid is dilerent: If a slip motion occurs there are strong rearrangements in the ring distribution as compared to the equilibrium case. Rings of medium size break and, as a result of this, sm all and large rings are formed (the same eld equilibrium for slip motion: Slip seems to occur only if the external (gravitational{like) force eld is strong enough to break rings of medium length. This slip mechanism can be expected to be generic for liquids with a tetrahedral order (of course, as before, only if walls are present that do not have a (strong) covalent bonding with the particles in the tetrahedral network).

As expected from hydrodynamic theory of a Newtonian uid we nd parabolic velocity proles in the bulk region, although the latter region extends in the system's considered in this work only over about 15 A. The values of the shear viscosity that we have extracted from the proles are in fair agreement with the \G reen {K ubo" values from a bulk simulation. So the question arises whether the non {equilibrium molecular dynamics technique used in this work o ers a method to estimate transport coe cients. It has been demonstrated for a lattice gas model [52] that non {equilibrium simulation techniques can be very powerful to gain insight into the understanding of transport processes in binary mixtures. We have shown in this work that with the present simulations this is possible for melts with a viscosity up to about 1 Poise. For system's with higher viscosities (at lower temperatures) a di erent wallm odelwould be helpful with which the tendency for slip motion is smaller and furtherm ore, larger system sizes would be required. But for larger system sizes one needs for the computation of the quasi{two{dimensionalCoulomb forces faster methods than the Parry{Ewald method used in this work. A promising new method [26,27] (also based on Ewald sums) that scales with the number of particles like N log N has been proposed very recently and could be applied to system s like the one considered in this work.

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FIGURES

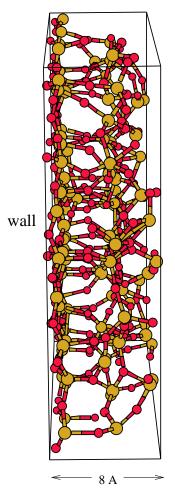


FIG.1. Snapshot of a part of a con guration at T = 3760 K that is within 8A away from the wall. The brown and the red spheres correspond to the silicon and oxygen atom s, respectively.

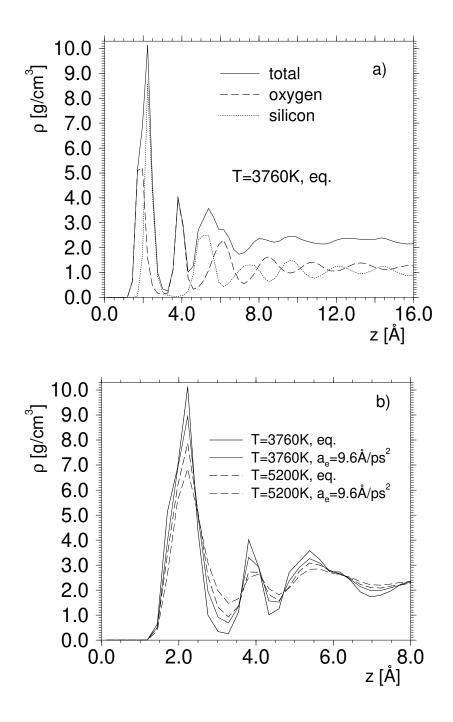


FIG.2.a) Total density pro le and partial density pro les for oxygen and silicon at T = 3760 K. b) Total density pro les at equilibrium and with acceleration eld $a = 9:6 \text{ A} = ps^2$ for the two tem peratures T = 3760 K and T = 5200 K.

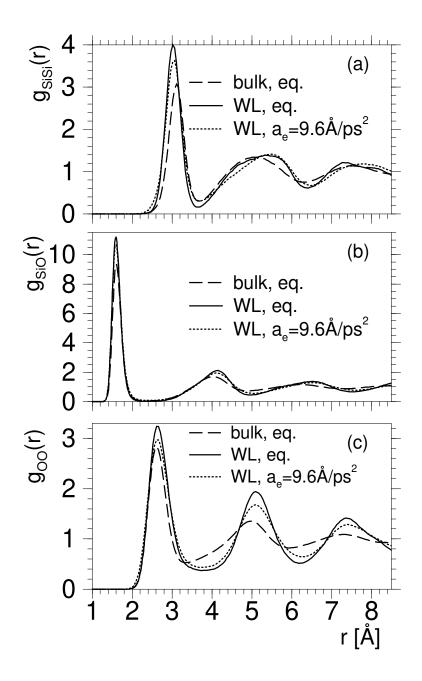


FIG.3. Partial radial distribution functions g (r) at equilibrium in the bulk and in the W L, and with the eld $a_e = 9:6 \text{ A} = ps^2$ in the W L.The tem perature is $T = 3760 \text{ K} \cdot a$) g_{SiSi} , b) g_{SiO} , c) $g_{OO} \cdot$

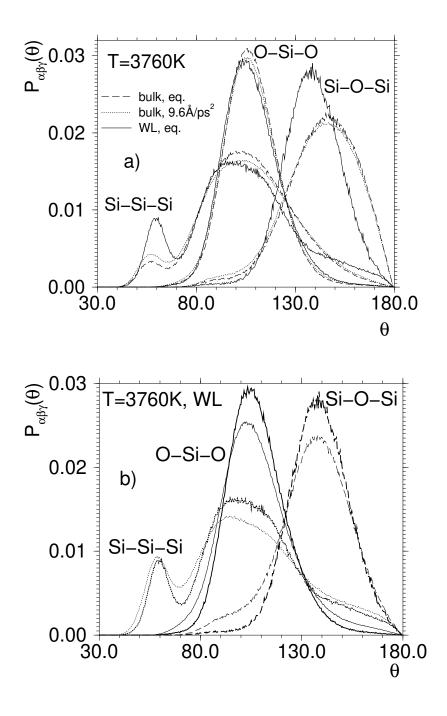
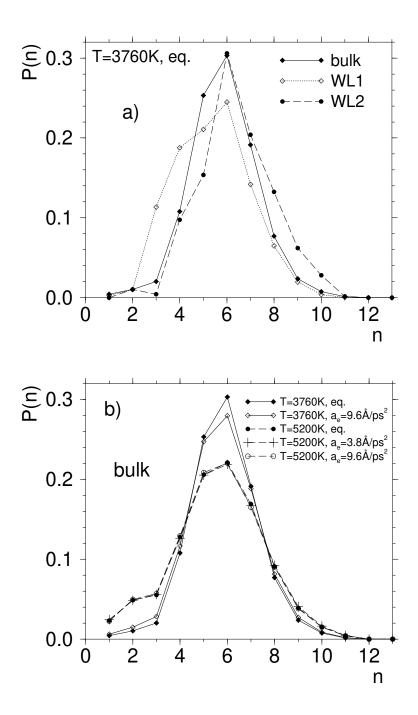


FIG. 4. Distributions of the indicated angles at equilibrium and with external eld $a_e = 9.6 \text{ A} = ps^2$ for T = 3760 K.a) Bulk and W L (at equilibrium), b) W L at equilibrium (bold lines) and with external eld (thin lines).



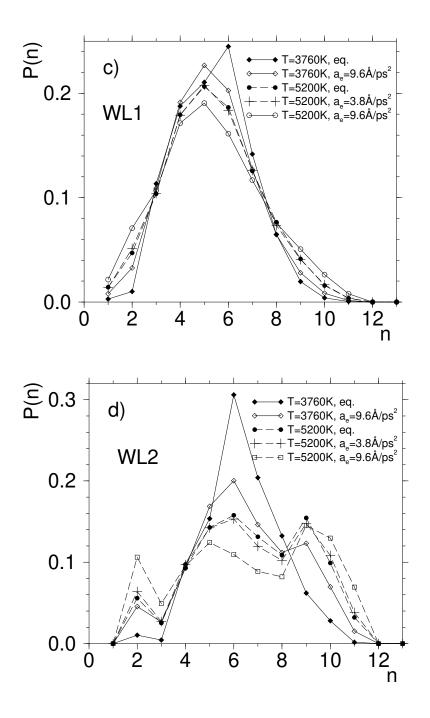
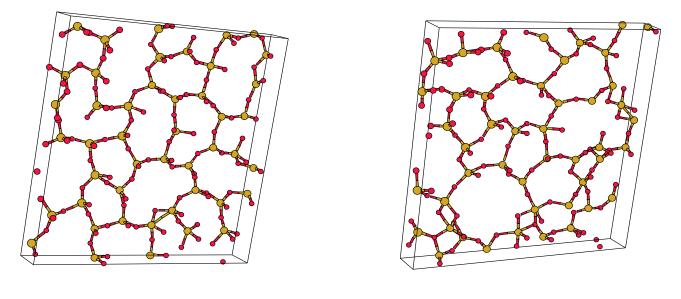


FIG.5. Probability P (n) that a ring has a length n, a) at T = 3760 K in equilibrium for the bulk, W L1, and W L2, b) at T = 3760 K and T = 5200 K in equilibrium and under the indicated acceleration elds in the bulk, c) the same as in b) but for W L1, and d) also the same as in b) but for W L2. For the de nition of W L1 and W L2 see text.



a)

b)

FIG.6. Snapshot of the wall layers (W L2) for T = 3760 K, a) at equilibrium and b) with the acceleration eld $a_e = 9:6 \text{ A} = ps^2$ (the direction of a_e is from the left to the right). The dark and the light grey spheres correspond to the silicon and oxygen atom s, respectively.

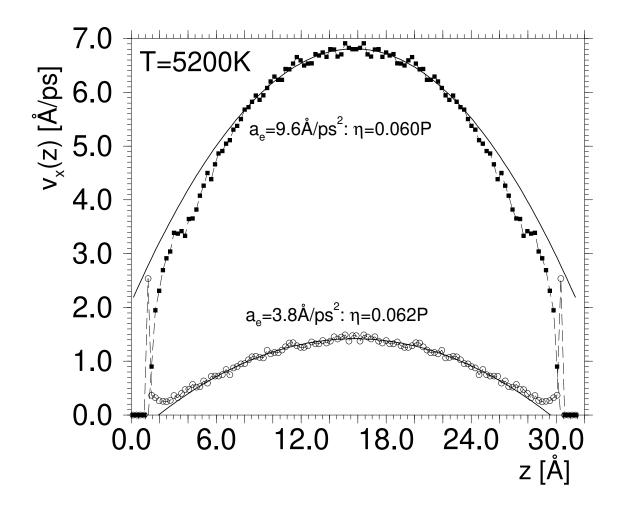


FIG.7. Velocity pro les at T = 5200 K for the indicated acceleration elds. The bold lines are ts with formula (3) and the indicated values for the shear viscosity are extracted from these ts.

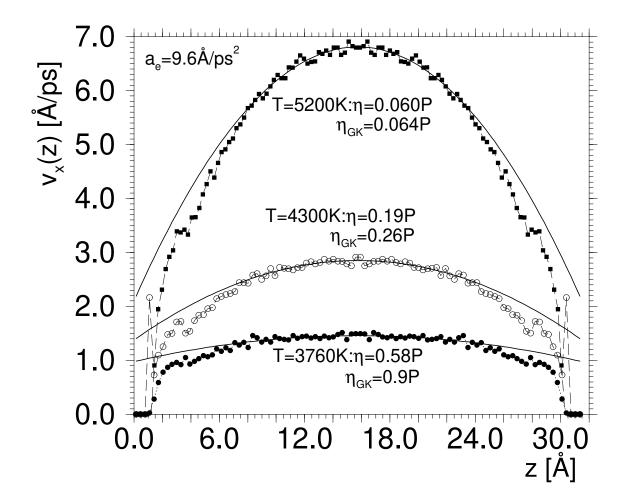


FIG.8. Velocity pro les for $a_e = 9:6 \text{ A} = ps^2$ at di errent tem peratures. _{GK} denotes the \G reen {K ubo" results that are taken from H orbach and K ob [36]. The rest is similar to Fig.7.